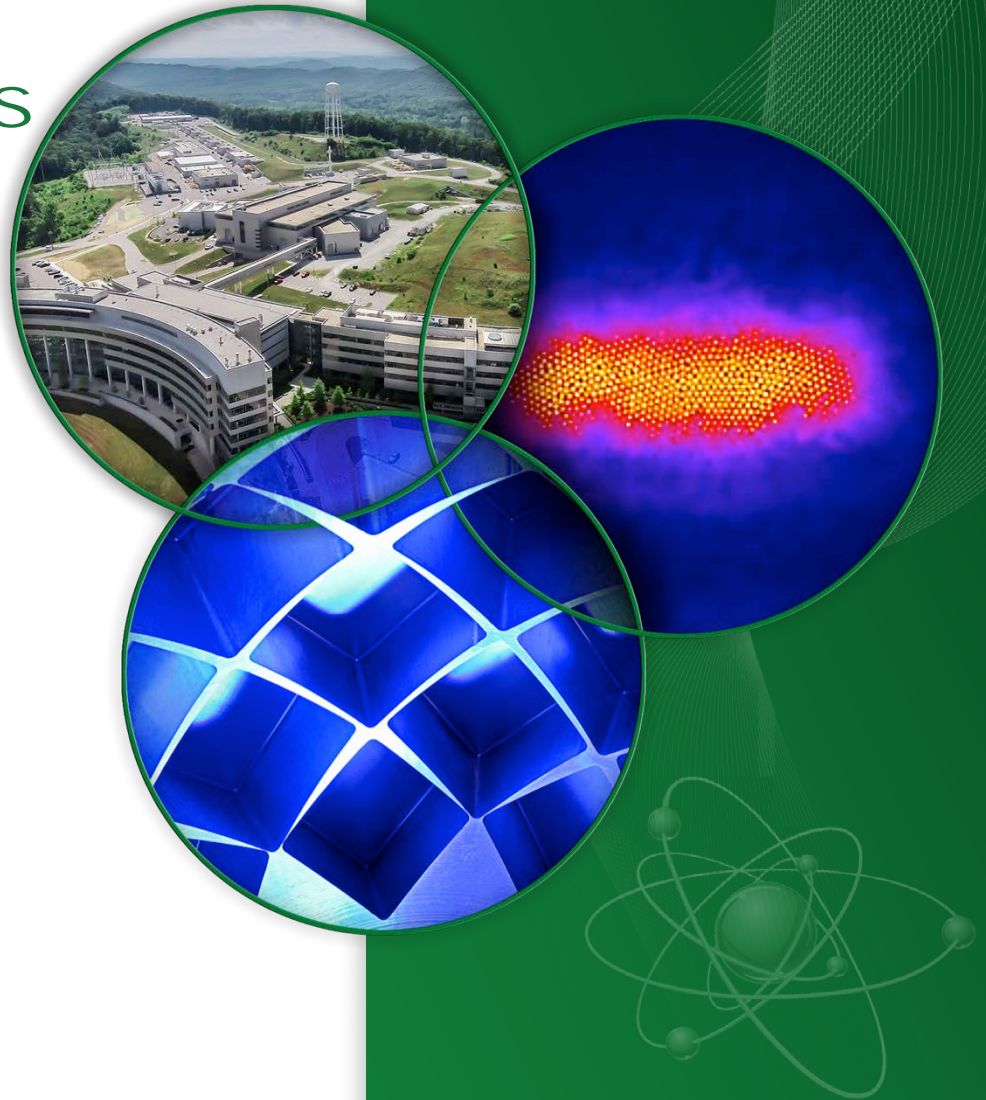


Measurement of 6D Beam Distributions at Low Beam Energy

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Outline

- Introduction
 - What
 - Why
 - How
 - Challenges
- Practical Implementation
 - SNS Integrated Test Stand Facility
 - 6D distribution measurement tools
- Status and Plans

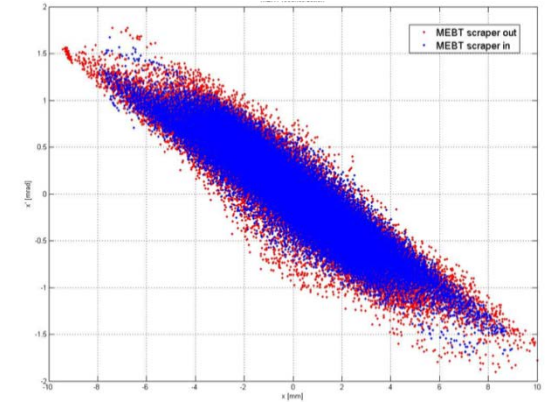
We will measure charge distribution function in 6D beam phase space

x, x', y, y', w, φ - coordinates in phase space

$f_2(x, x')$ - 2D distribution function \longrightarrow

$f_4(x, x', y, y')$ - 4D distribution function

$f_6(x, x', y, y', w, \varphi)$ - 6D distribution function



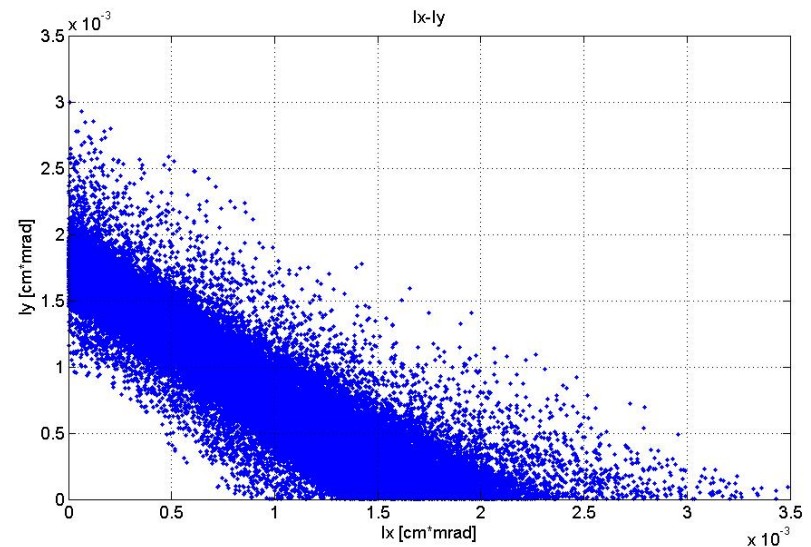
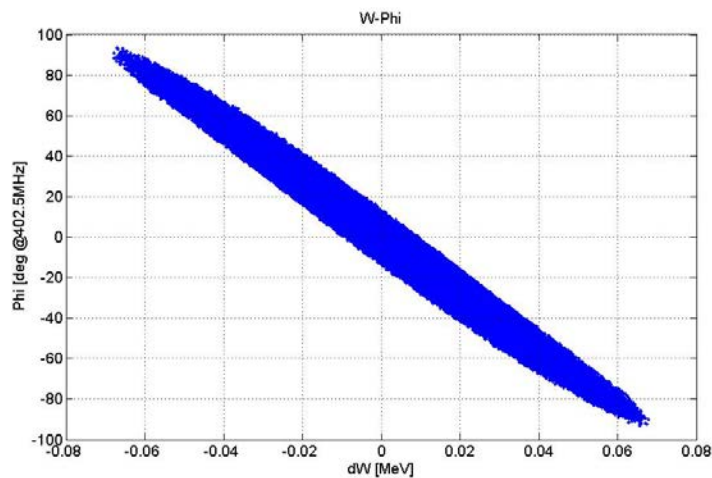
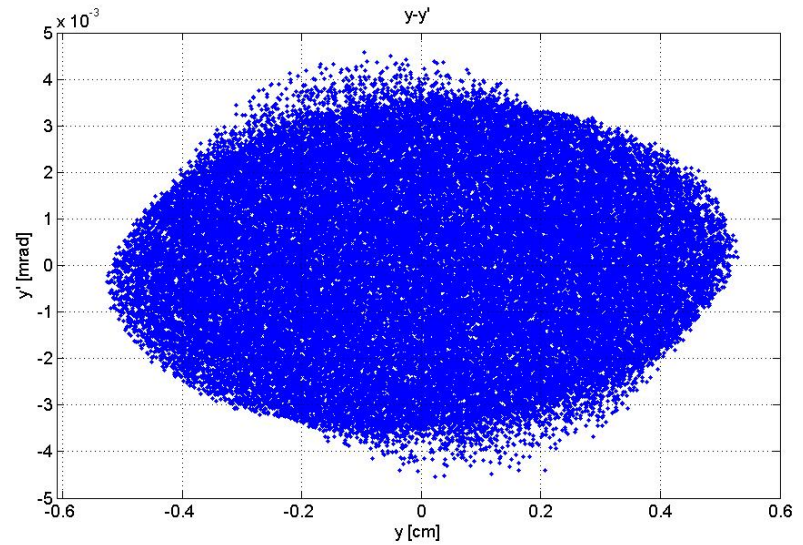
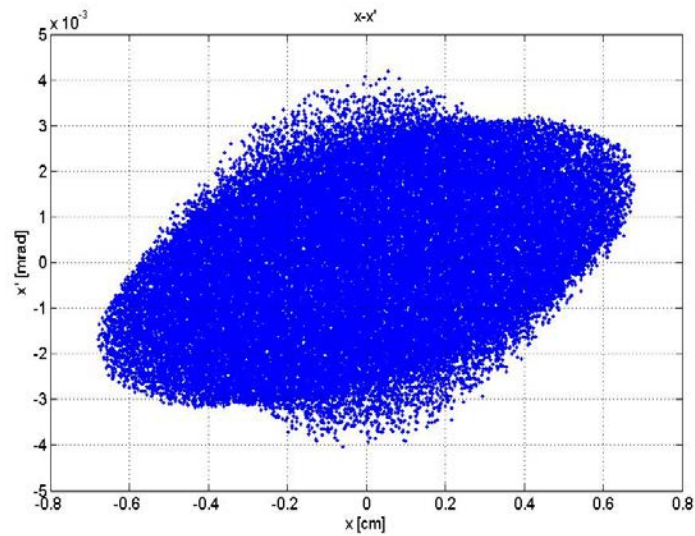
$$f_{3*2}(x, x', y, y', w, \varphi) = f_2(x, x') \cdot f_2(y, y') \cdot f_2(w, \varphi)$$

\uparrow
sometimes called 6D but

$$f_{3*2}(x, x', y, y', w, \varphi) \neq f_6(x, x', y, y', w, \varphi)$$

except for special case of no any correlations between degrees of freedom

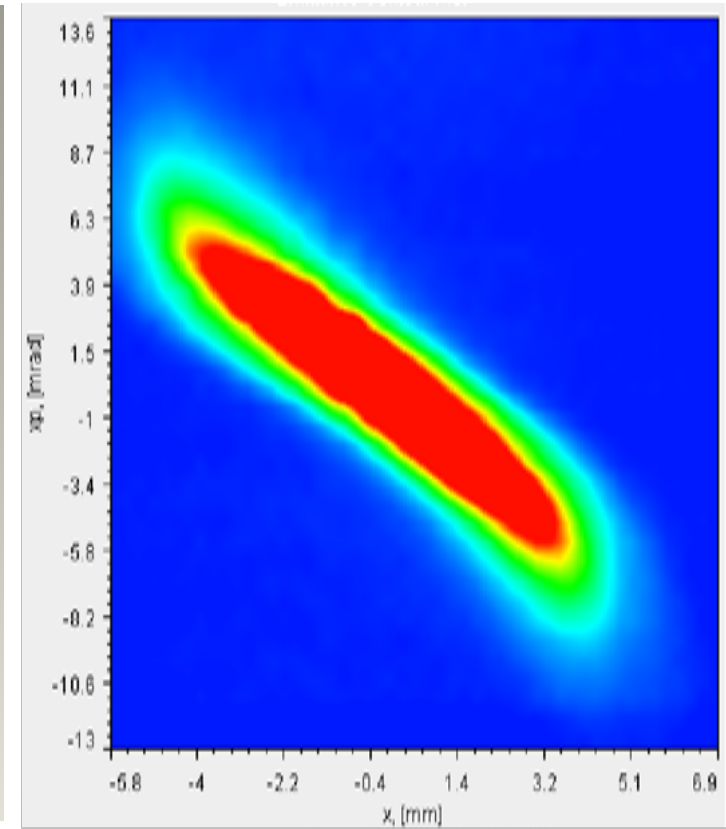
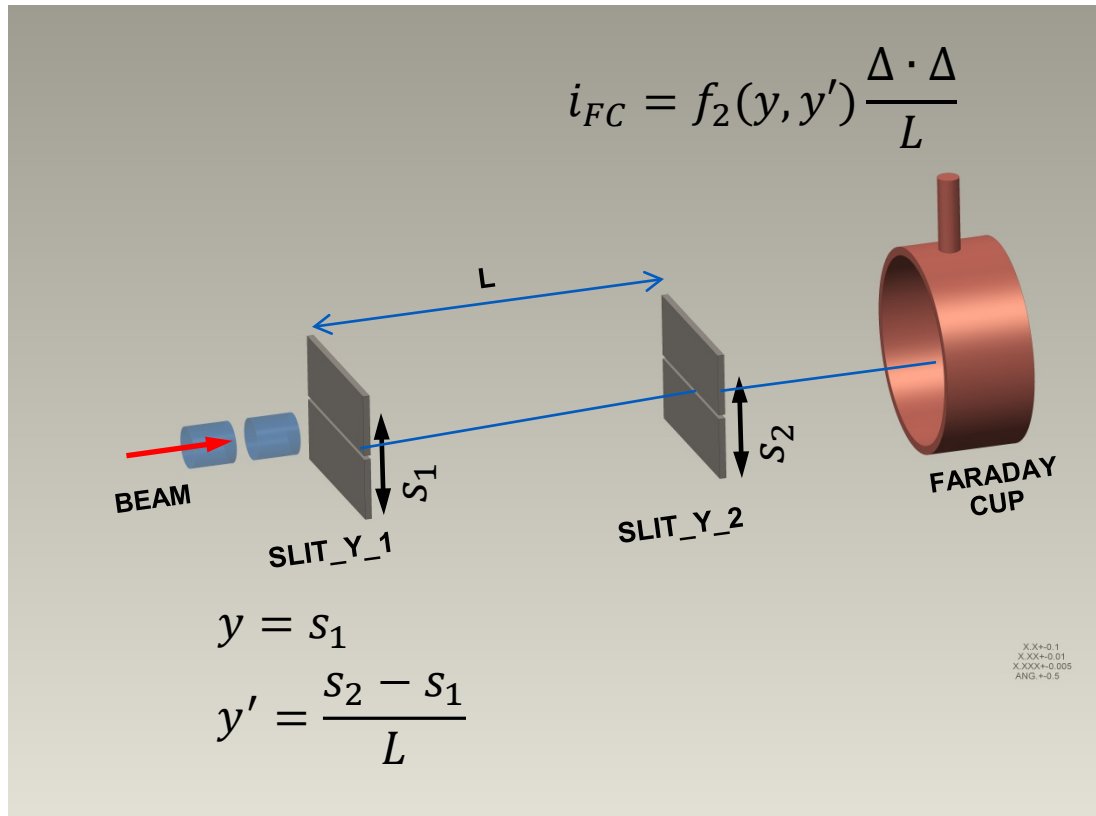
Example: 'K - V like' distribution



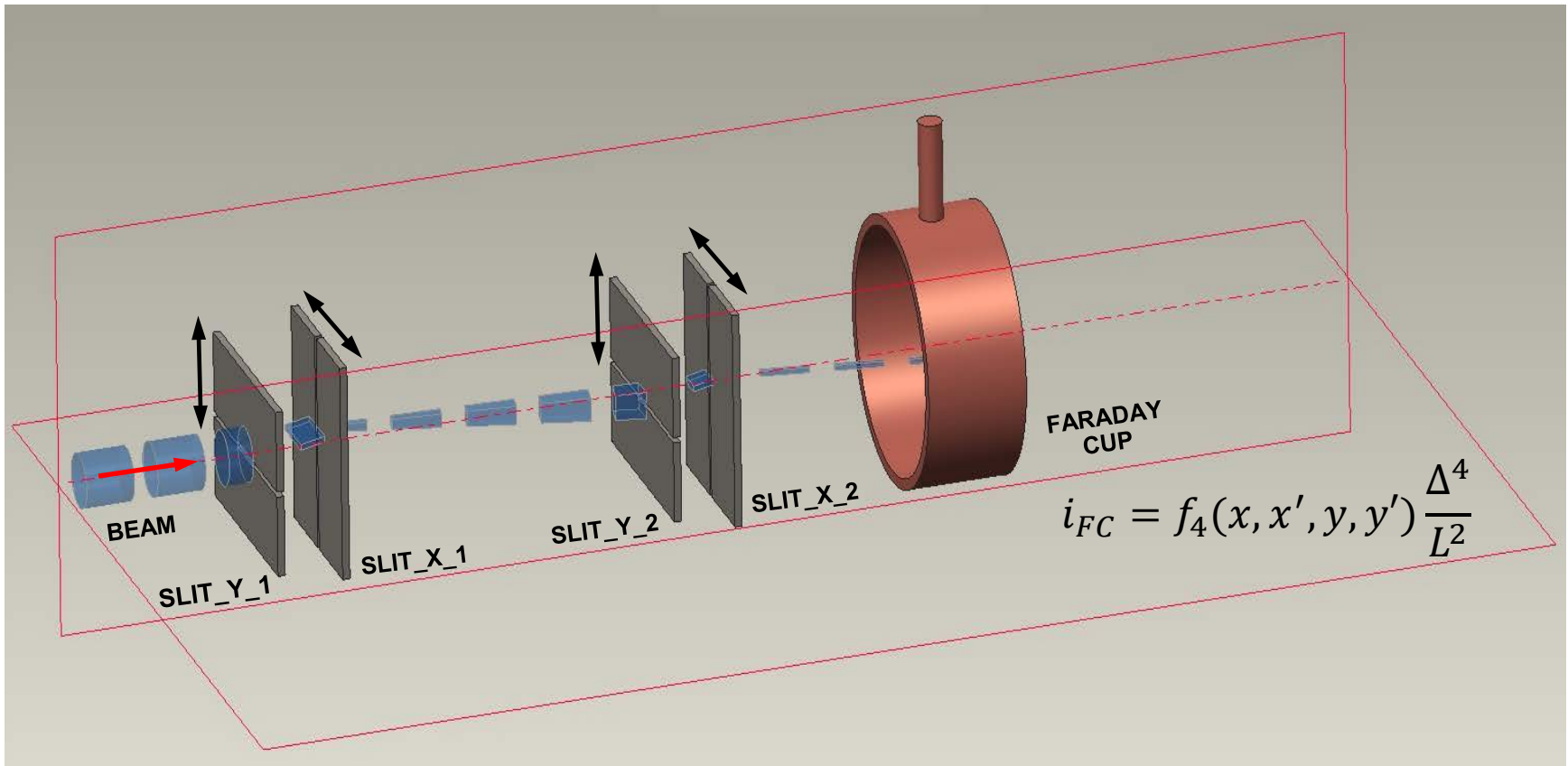
Realistic initial distribution is needed for PIC simulation of beam dynamics in linac

- End-to-end simulation starting from ion source plasma surface
 - No comments
- 4D distribution measurement after ion source + PIC simulation through RFQ
 - Accurate 4D measurement at RFQ entrance is difficult
 - Beam dynamics simulation in RFQ is most challenging part of linac simulation: strong space charge, many cells, no diagnostics
- 6D distribution reconstruction from 1 or 2D measurements after RFQ
 - Absence of correlations between degrees of freedom is assumed without experimental validation
 - Dedicated experiment (LEDA) did not support this approach
- Direct measurement of 6D distribution after RFQ

2D distribution measurement (emittance) using slit-slit technique



4D distribution measurement using four slits arrangement



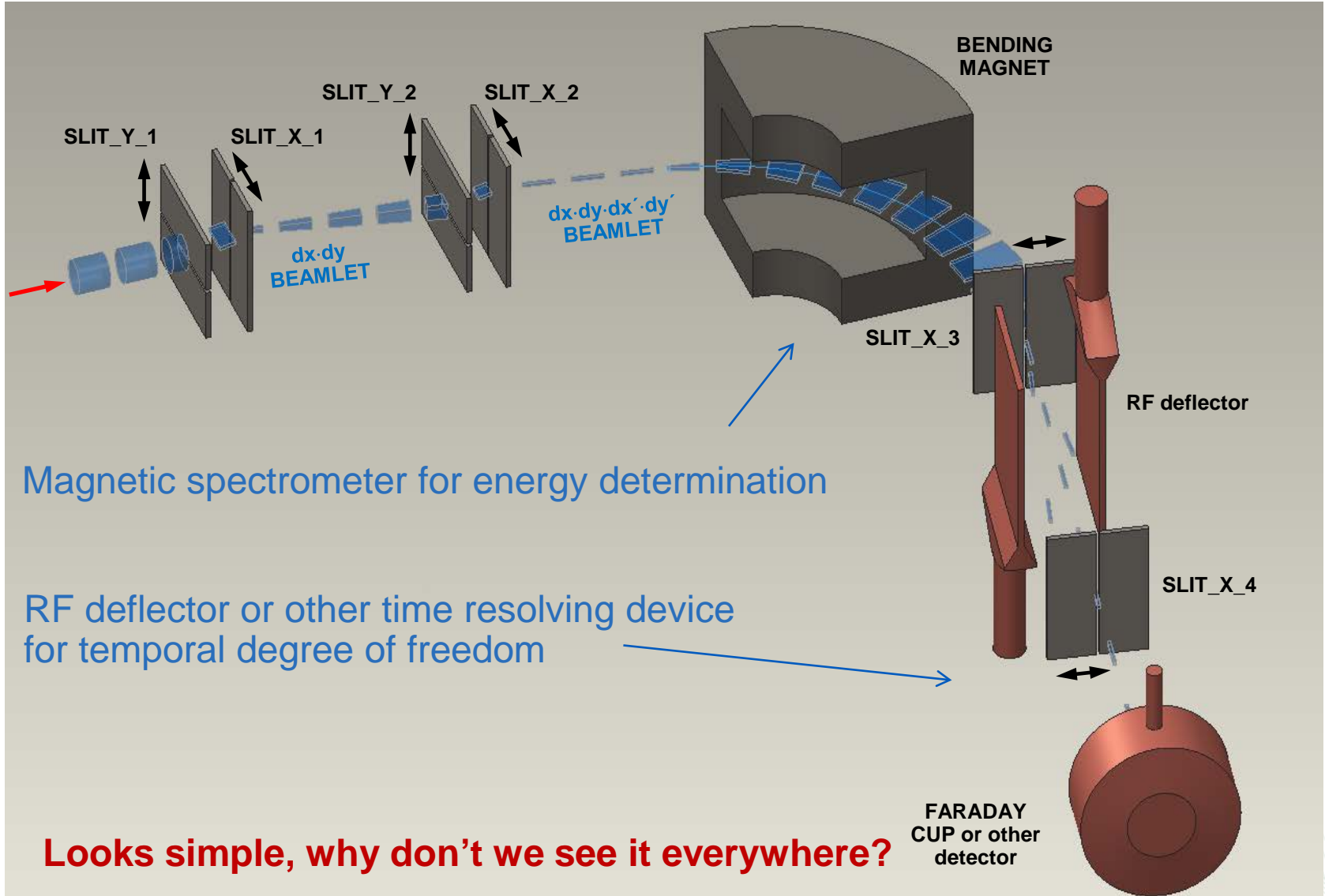
$$x = s_{x1}$$

$$y = s_{y1}$$

$$x' = \frac{s_{x2} - s_{x1}}{L}$$

$$y' = \frac{s_{y2} - s_{y1}}{L}$$

6D distribution measurement arrangement



“Curse of dimensionality” problem

- High-dimensional spaces have very large volume: $V \sim a^D$
 - Large scan time
 - Low charge density
 - Large data sets
- Same setup can measure all lower dimension projections

$x - x'$

$x - y$

$x - \varphi$

$x - w$

x' - y - x

x' - φ - x

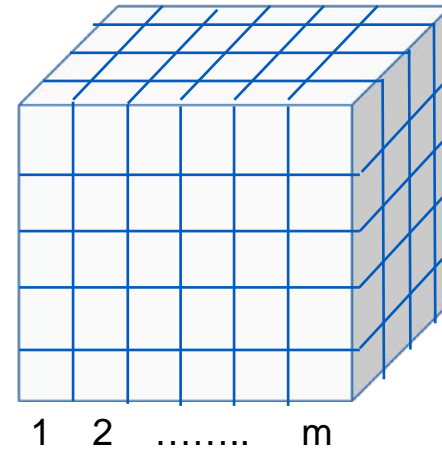
x' - w - x

....

Scan time estimate

$$N_{bins} = m^D$$

\uparrow Total number of bins
 \nwarrow Number of steps per degree of freedom
 \leftarrow dimensionality

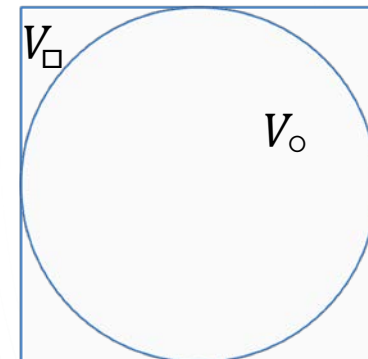


For $m = 10, D = 6$ $N_{bins} = 10^6$

Total scan time at 1 $\frac{step}{sec}$: $T_{total} = 10^6 sec = 280 hours$

Total scan time at 10 $\frac{step}{sec}$: $T_{total} = 10^5 sec = 28 hours$

$$\frac{V_o}{V_{\square}} = \frac{\pi^{D/2}}{\Gamma(D/2 + 1)2^D} = \begin{cases} .79; & D = 2 \\ .52; & D = 3 \\ .081; & D = 6 \end{cases}$$



Tens of hours total scan time

Signal strength estimate

$$i = I_0 \cdot \frac{\exp(-\frac{x^2}{2\sigma_x^2} - \frac{x'^2}{2\sigma_{x'}^2} - \frac{y^2}{2\sigma_y^2} - \frac{y'^2}{2\sigma_{y'}^2} - \frac{w^2}{2\sigma_w^2} - \frac{\varphi^2}{2\sigma_\varphi^2})}{8\pi^3} \frac{\Delta_x}{\sigma_x} \frac{\Delta_{x'}}{\sigma_{x'}} \frac{\Delta_y}{\sigma_y} \frac{\Delta_{y'}}{\sigma_{y'}} \frac{\Delta_w}{\sigma_w} \frac{\Delta_\varphi}{\sigma_\varphi} \approx \frac{\exp(\dots)}{8\pi^3} (\Delta/\sigma)^6$$

For $\Delta/\sigma \approx .2$ current after all 6 slits $i \approx I_0 \cdot 2.6 \cdot 10^{-7} \cdot \exp(\dots)$

Number of particles in $I_0 \approx 32 \text{ mA}$, $\tau \approx 50 \mu\text{s}$ beam pulse is $N_0 \approx 10^{13}$

Number of particles after 6 slits: $N_{FC} \approx 2.6 \cdot 10^6$ at the distribution center $r = 0$

$$N_{FC} \approx 1.3 \cdot 10^5 \text{ at } \bar{X} = 1 \sigma$$

$$N_{FC} \approx 16 \text{ at } \bar{X} = 2 \sigma$$

$$N_{FC} \approx 4.9 \cdot 10^{-6} \text{ at } \bar{X} = 3 \sigma$$

$$N_{FC} \approx 3.5 \cdot 10^6 \text{ at } r = 2 \sigma$$

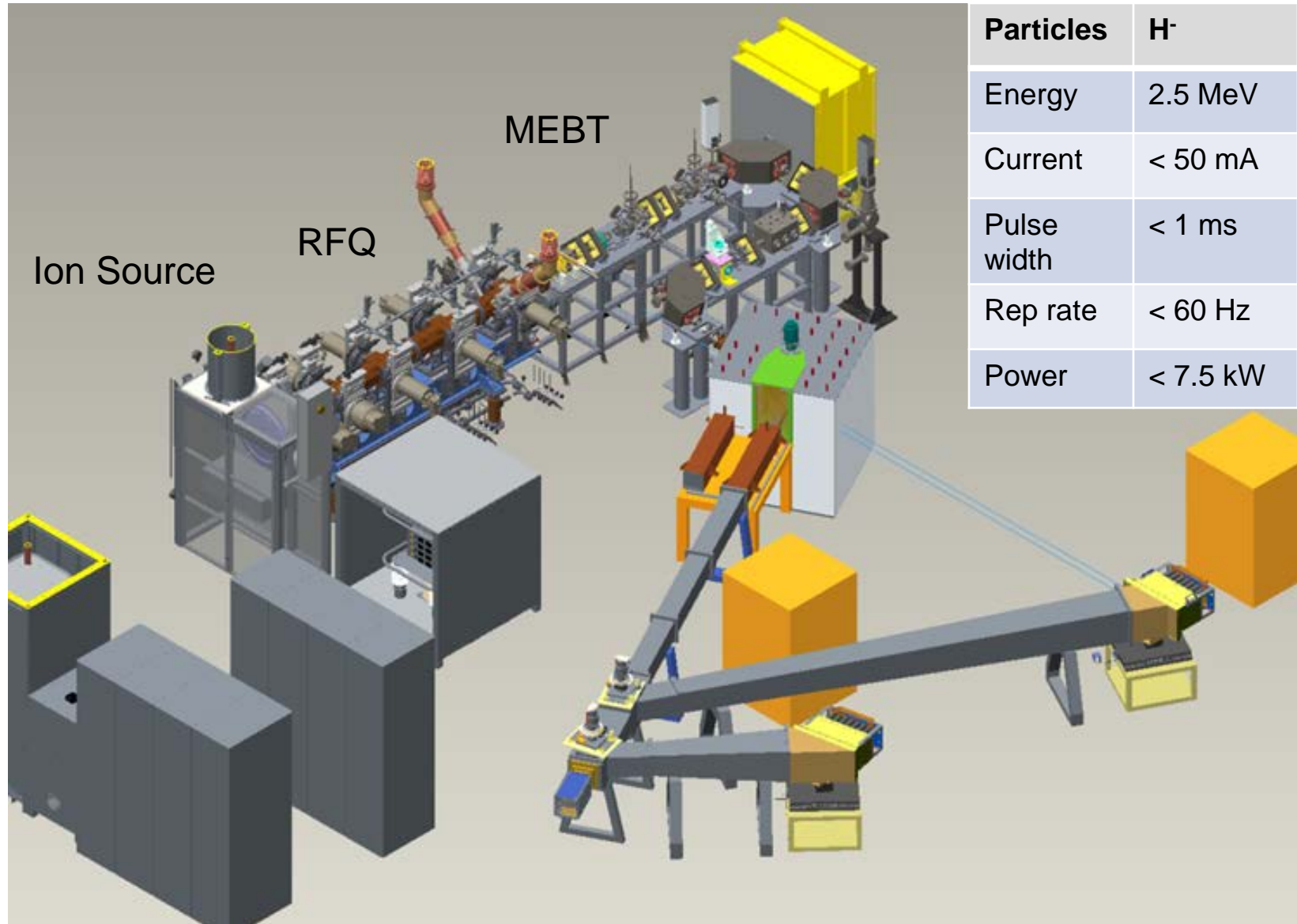
$$N_{FC} \approx 2.9 \cdot 10^4 \text{ at } r = 3 \sigma$$

$$N_{FC} \approx 9.7 \text{ at } r = 5 \sigma$$

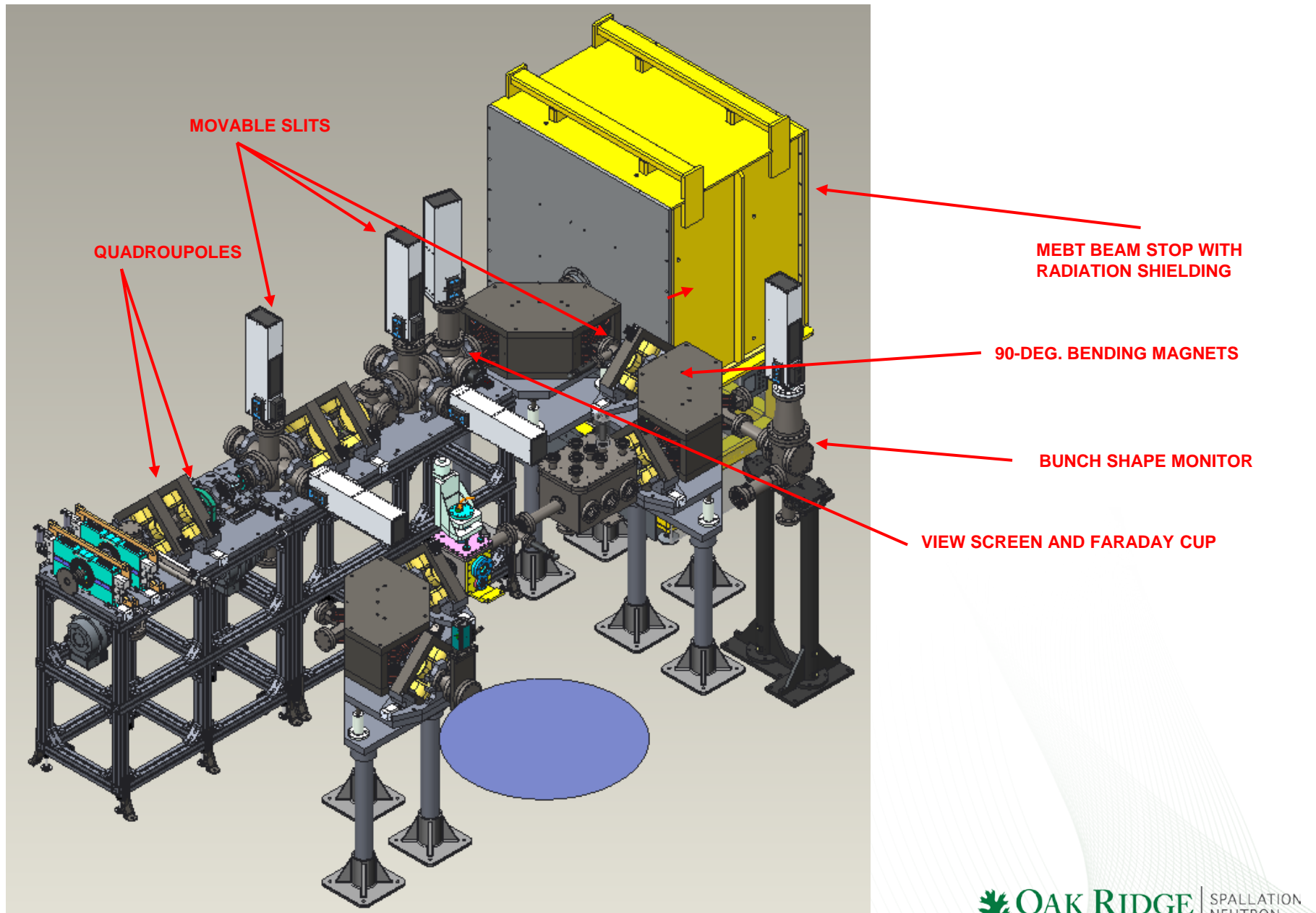
Many hours of beam time allocated
for single experiment
is big challenge for any large scale
accelerator facility

Only feasible at a dedicated facility

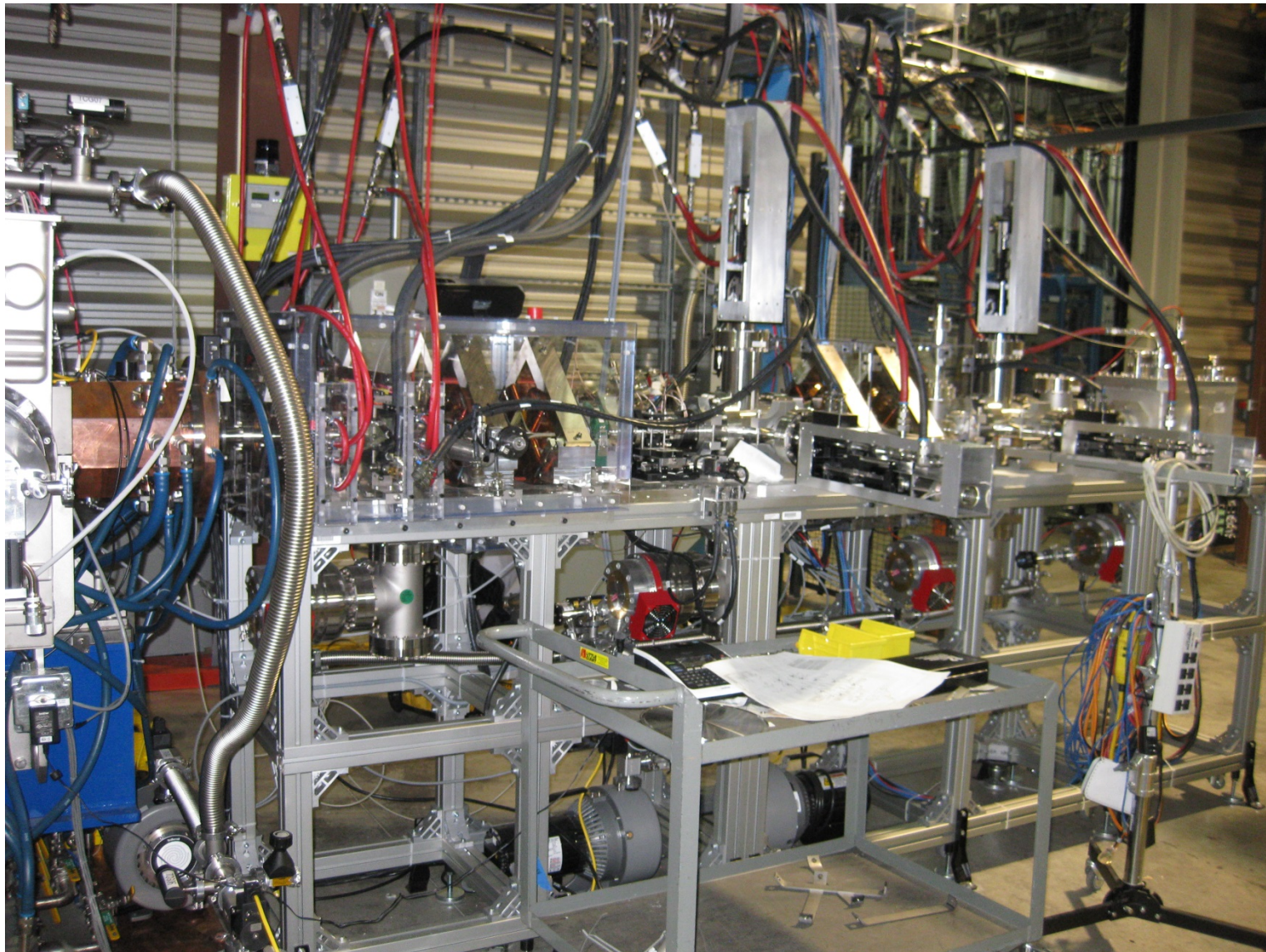
SNS Integrated Test Stand Facility (ITSF)



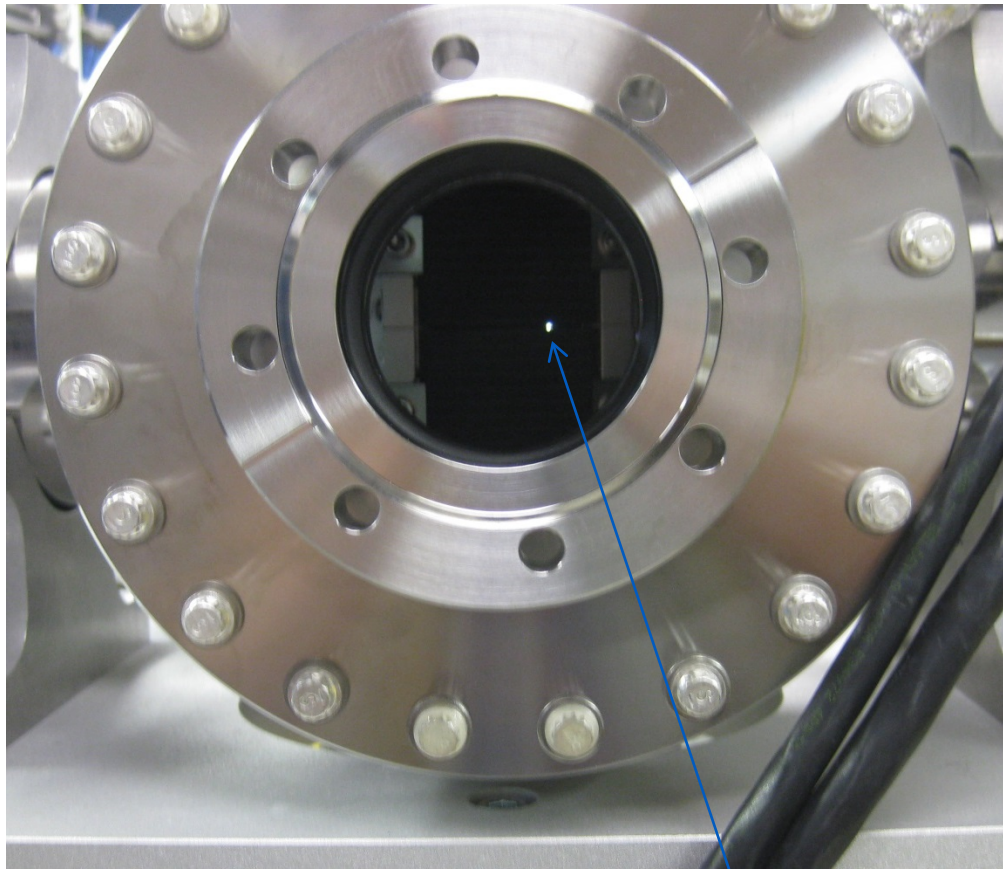
ITSF Diagnostics Beam Line Layout



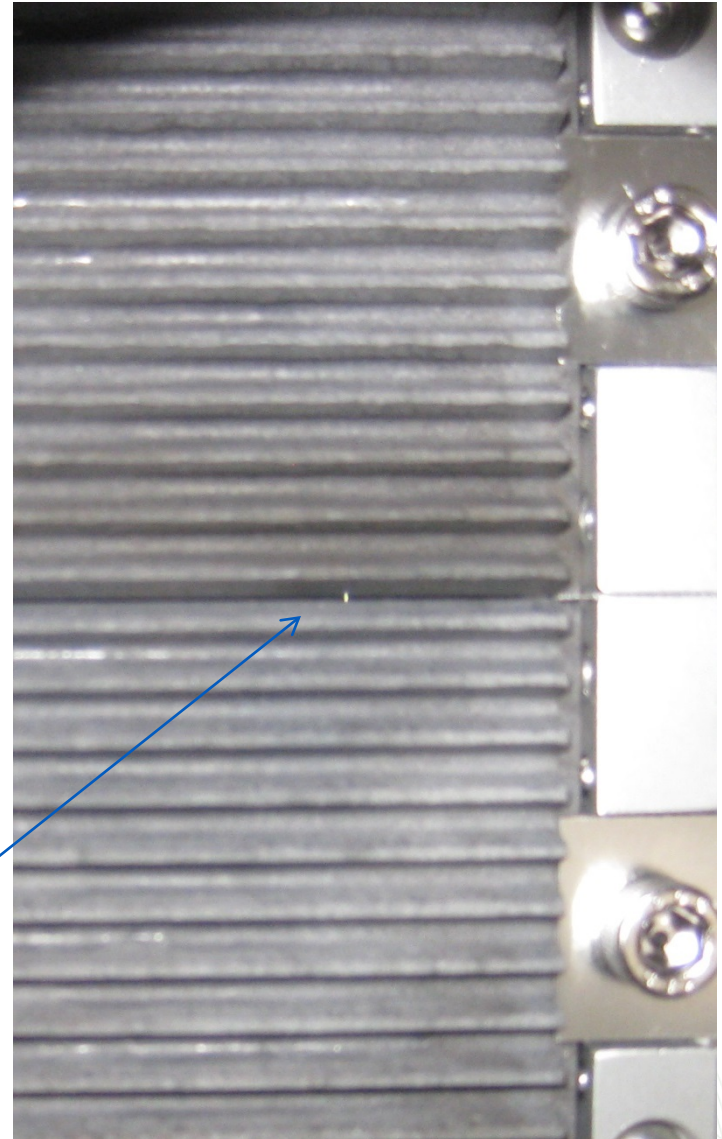
ITSF MEBT



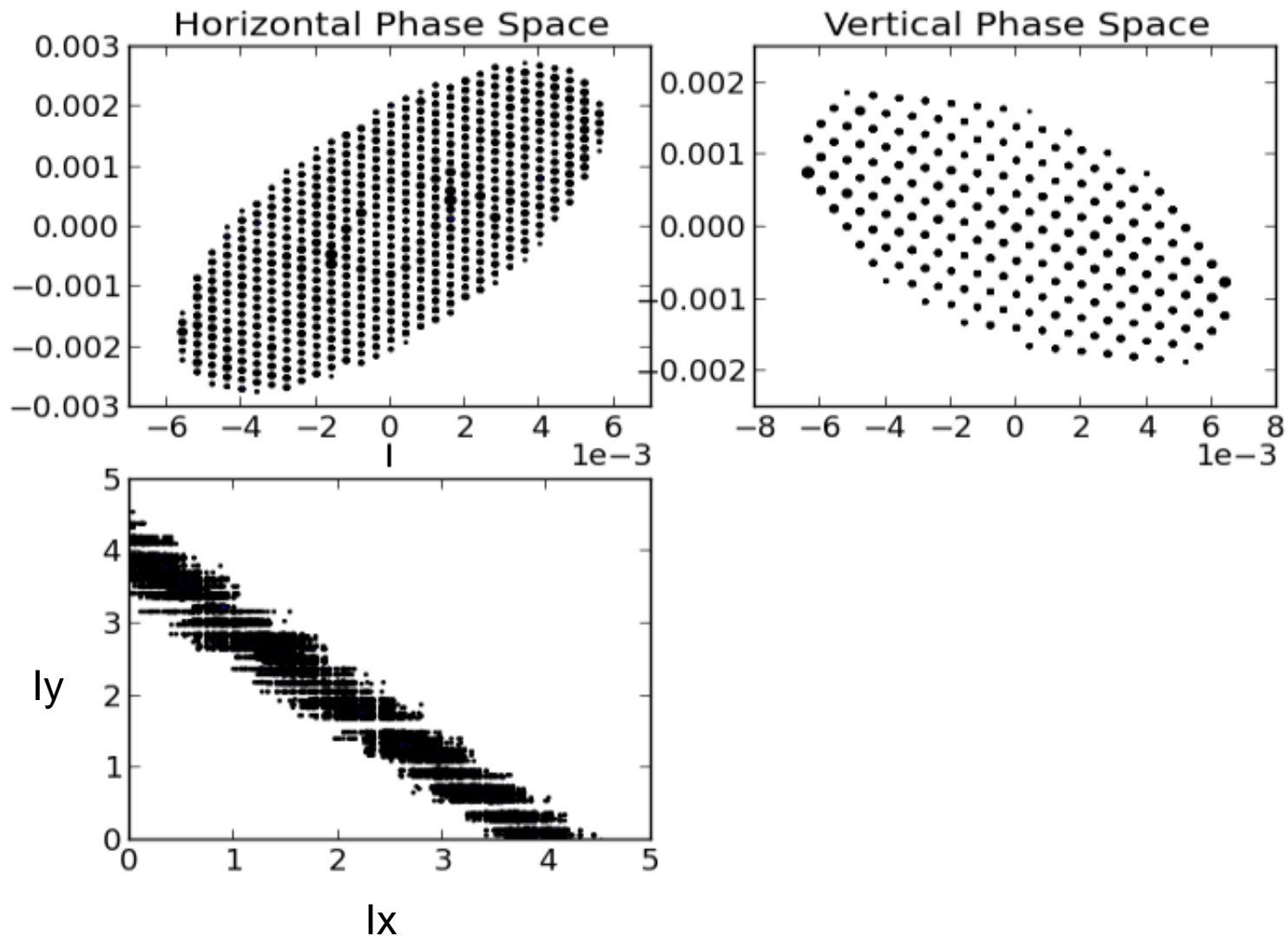
X-Y Slit arrangement



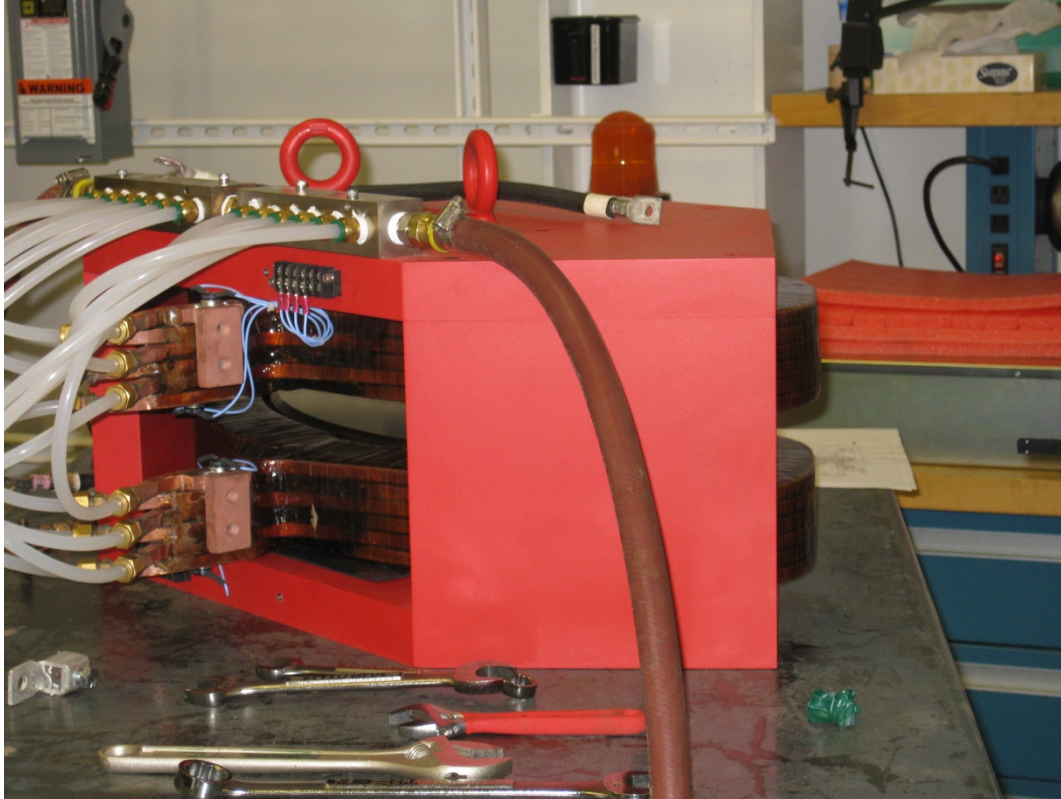
200-by-200 μm aperture



Simulated scan of 'K - V like' distribution

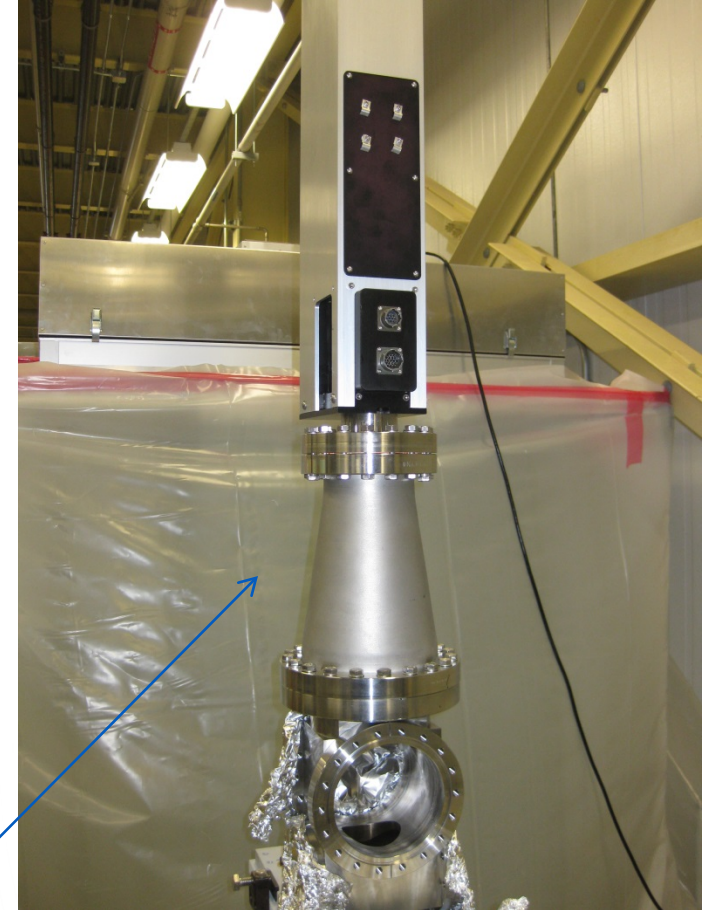


Equipment for E- ϕ degrees of freedom measurement to be installed



90° bending magnet

‘RF deflector’ type longitudinal profile monitor,
aka ‘Feschenko device’

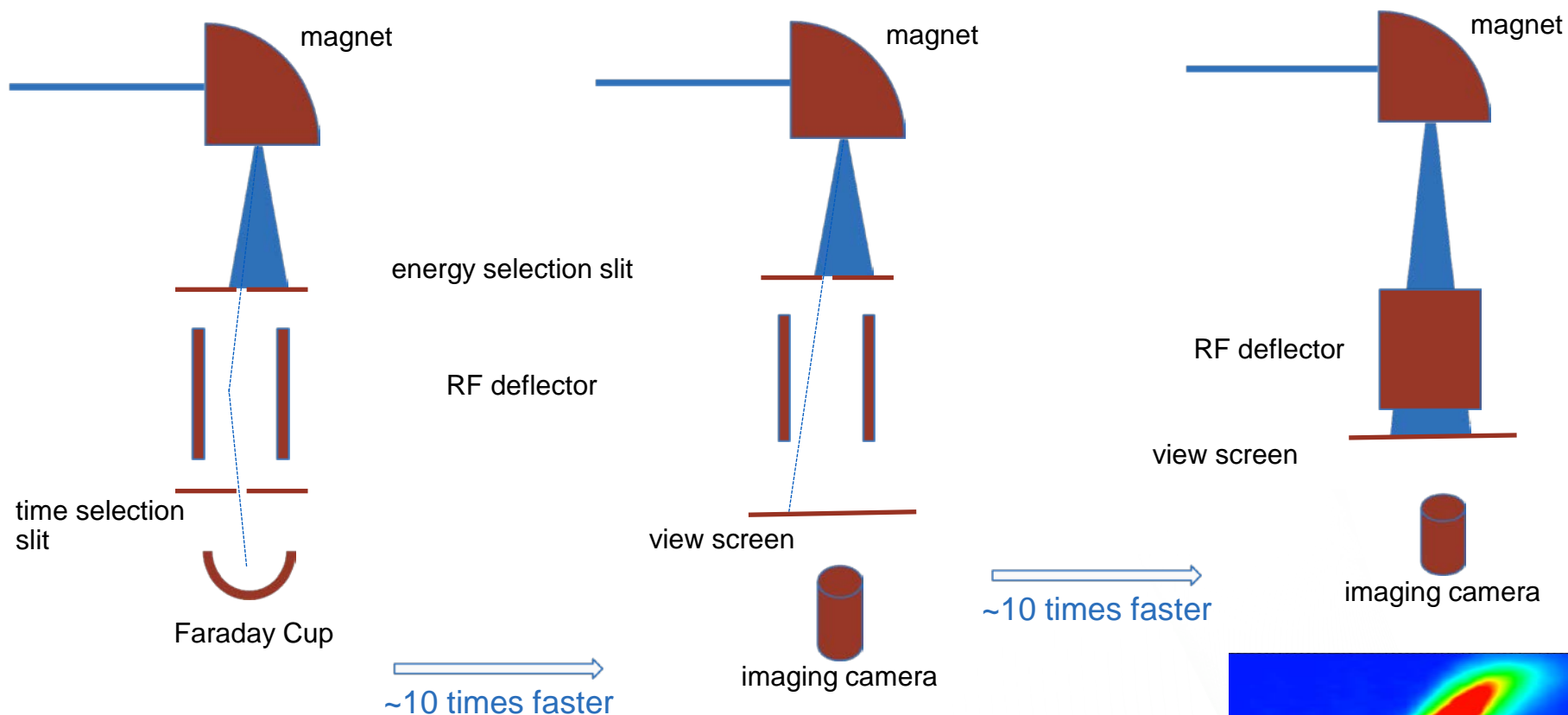


Status

- Ion Source
- RFQ
- Straight beam line
- Safety systems, documentation
- DOE approval
- 90° bend beam line

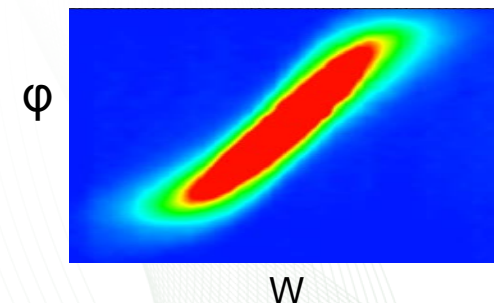
operational
operational
operational
in progress
eventually
spring 2016

Speeding up W- ϕ plane measurement

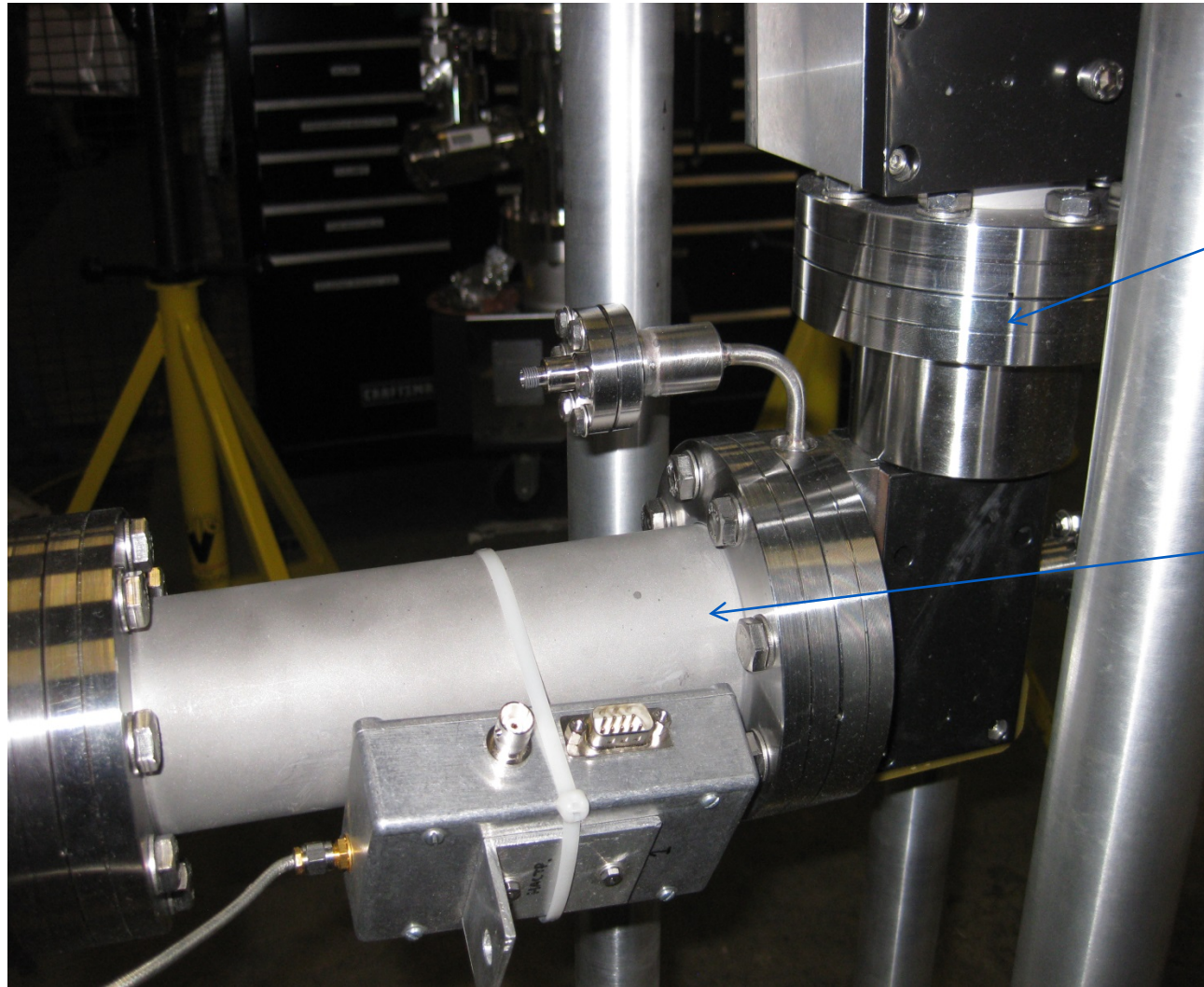


- 2D optical readout has advantages and disadvantages

- faster
- smaller dynamic range of charge-to-light-to-charge conversion



Detector modification is simple



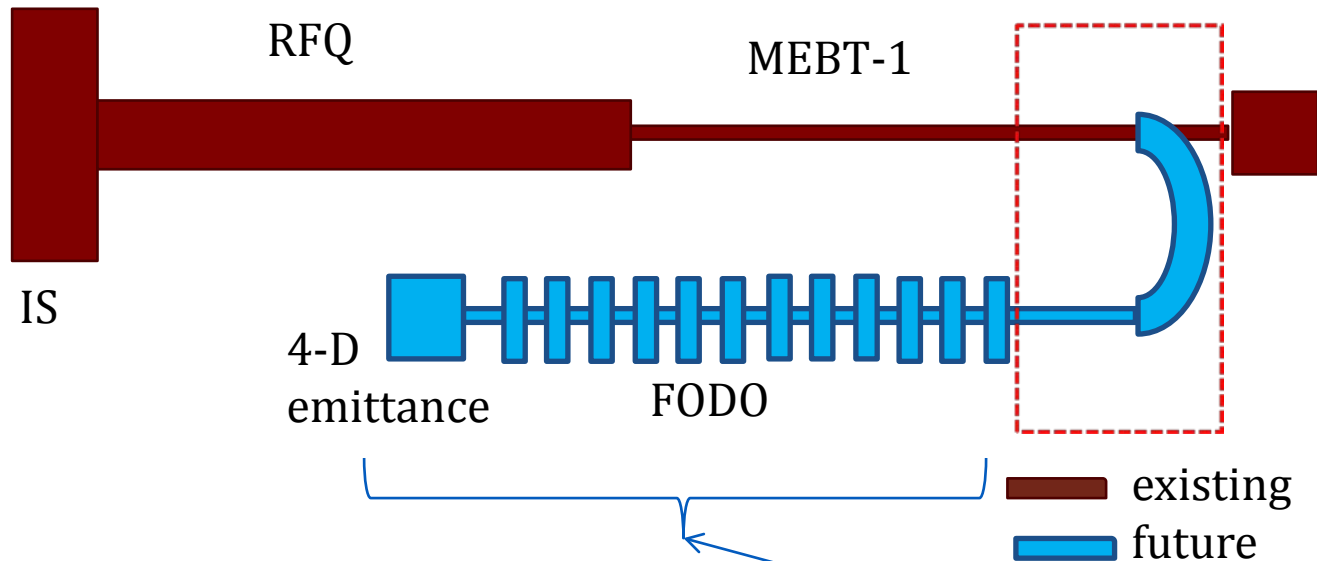
Slit mounted on this flange
to be replaced
with view screen

SEM and Faraday Cup
to be replaced
with digital camera

Research goals

- Optimize 6D phase space measuring system for maximum resolution and dynamic range
- Develop algorithm for generating particle distributions for loading to PIC codes
- Search for high-dimensional correlations in the measured distribution
- Develop and verify methods of generating 6D distributions from low-dimensional projections
- Repeat LEDA beam dynamics experiment with newly developed diagnostics

US National Science Foundation Grant with University of Tennessee (Sarah Cousineau is PI)



- Proposal highlights:
 - Direct 6D phase space measurement.
 - Study halo formation in FODO structure.
 - Benchmark codes (community resource), evaluate diagnostics.
 - Funding for 1 postdoc, 1 graduate student, 3 undergraduates for 3 years beginning in September 2015.

LEDA style beam dynamics experiment
To be designed, built and commissioned at ITSF

Thank you for your attention!